

N CHANNEL ENHANCEMENT MODE POWER MOSFET

Description:

RS60N25D Series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance . it provides the designer with an extreme efficient device for use in a wide range of power applications

The T0-252 package is widely preferred for all commercial industrial surface mount applications using infrared reflow technique and suited for high current application due to the low connection resistance

Features:

- Lower On-resistance
- Simple Drive Requirement
- Fast Switching Characteristic
- RoHS Compliant

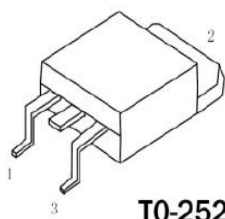
Ordering Information

| Part Number | Package | Marking  |
|-------------|---------|----------|
| RS60N25D    | T0-252  | RS60N25D |



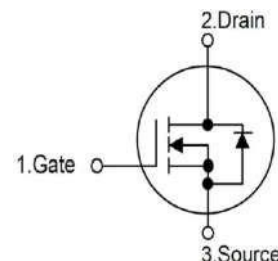
Lead Free Package and Finish

| $I_D$ | $R_{DS(ON)} (Max)$ | $V_{DS}$ |
|-------|--------------------|----------|
| 25A   | 36mΩ               | 60V      |



T0-252

Not to Scale



Not to Scale

Absolute Maximum Ratings Tc=25°C unless otherwise specified

| Symbol                 | Parameter  | Rating     | Units |
|------------------------|--|------------|-------|
| $V_{DS}$               | Drain-Source Voltage                             | 60         | V     |
| $V_{GS}$               | Gate-Source Voltage                              | ±20        | A     |
| $I_D @T_c=25^\circ C$  | Drain Current                                    | 25         |       |
| $I_D @T_c=100^\circ C$ | Drain Current, Vgs@10V                           | 16         |       |
| $I_{DM}$               | Pulsed Drain Current (Note*1)                    | 80         |       |
| $P_D @T_c=25^\circ C$  | Total Power Dissipation                          | 35         | W     |
| $T_L$<br>TPKG          | Maximum Temperature for Soldering                | 300<br>260 | °C    |
|                        | Leads at 0.063in(1.6mm) from Case for 10 seconds |            |       |
|                        | Package Body for 10 seconds                      |            |       |
| $T_J$ and $T_{STG}$    | Operating Junction and Storage Temperature Range | -55 to 150 |       |

Caution:Stresses greater than those listed in the “Absolute Maximum Ratings” Table may cause permanent damage to the device.

Thermal Resistance

| Symbol      | Parameter   | Value | Units |
|-------------|---|-------|-------|
| $R_{thj-c}$ | Maximum Thermal Resistance, Junction-case                 | 3.6   | °C/W  |
| $R_{thj-a}$ | Maximum Thermal Resistance, Junction-ambient <sup>3</sup> | 62.5  | °C/W  |

**Electrical Characteristics @T<sub>J</sub>=25°C (unless otherwise specified)**

| Symbol            | Parameter                      | Min. | Typ. | Max. | Units | Test Conditions                           |
|-------------------|--------------------------------|------|------|------|-------|---|
| BV <sub>DSS</sub> | Drain-source Breakdown Voltage | 60   | --   | --   | V     | V <sub>GS</sub> =0V, I <sub>D</sub> =1mA  |
| I <sub>DSS</sub>  | Drain-Source Leakage Current   | --   | --   | 10   | μA    | V <sub>DS</sub> =60V, V <sub>GS</sub> =0V |
| I <sub>GSS</sub>  | Gate-Source Forward Leakage    | --   | --   | 100  | nA    | V <sub>GS</sub> =+20V V <sub>DS</sub> =0V |
|                   | Gate-Source Reverse Leakage    | --   | --   | -100 |       | V <sub>GS</sub> =-20V V <sub>DS</sub> =0V |
| g <sub>fs</sub>   | Forward Transconductance       | --   | 12.4 | --   | S     | I <sub>D</sub> =15A V <sub>DS</sub> =10V  |

**ON Characteristics T<sub>J</sub>=25°C unless otherwise specified**

| Symbol              | Parameter                                      | Min. | Typ. | Max. | Units | Test Conditions  |
|---------------------|--|------|------|------|-------|--|
| R <sub>DS(on)</sub> | Static Drain-Source On-Resistance <sup>2</sup> | --   | 28   | 36   | mΩ    | V <sub>GS</sub> =10V, I <sub>D</sub> =18A                |
|                     |  | --   | 42   | 50   | mΩ    | V <sub>GS</sub> =4.5V, I <sub>D</sub> =12A               |
| V <sub>GS(TH)</sub> | Gate Threshold Voltage                         | 1    | 1.6  | 3    | V     | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250μA |

**Resistive Switching Characteristics** Essentially independent of operating temperature

| Symbol              | Parameter           | Min. | Typ. | Max. | Units | Test Conditions   |
|---------------------|---------------------|------|------|------|-------|---|
| t <sub>d(on)</sub>  | Turn-on Delay Time  | --   | 6.6  | --   | nS    | V <sub>DS</sub> =30V<br>I <sub>D</sub> =15A<br>R <sub>g</sub> =3.3Ω<br>V <sub>GS</sub> =10V |
| t <sub>rise</sub>   | Rise Time           | --   | 22.2 | --   |       |   |
| t <sub>d(off)</sub> | Turn-OFF Delay Time | --   | 17   | --   |       |   |
| t <sub>fall</sub>   | Fall Time           | --   | 4.3  | --   |       |   |

**Dynamic Characteristics** Essentially independent of operating temperature

| Symbol           | Parameter                    | Min. | Typ. | Max. | Units | Test Conditions   |
|------------------|------------------------------|------|------|------|-------|---|
| C <sub>iss</sub> | Input Capacitance            | --   | 625  | 998  | pF    | V <sub>GS</sub> =0V<br>V <sub>DS</sub> =25V<br>f=1.0MHz             |
| C <sub>oss</sub> | Output Capacitance           | --   | 90   | --   |       |   |
| C <sub>rss</sub> | Reverse Transfer Capacitance | --   | 65   | --   |       |   |
| Q <sub>g</sub>   | Total Gate Charge            | --   | 17   | 27   | nC    | V <sub>DS</sub> =48V<br>I <sub>D</sub> =15A<br>V <sub>GS</sub> =10V |
| Q <sub>gs</sub>  | Gate-Source Charge           | --   | 2.5  | --   |       |   |
| Q <sub>gd</sub>  | Gate-Drain("Miller") Charge  | --   | 6.4  | --   |       |   |

Source-Drain Diode Characteristics

| Symbol   | Parameter                          | Min. | Typ. | Max. | Units | Test Conditions             |
|----------|------------------------------------|------|------|------|-------|-----------------------------|
| $V_{SD}$ | Diode Forward Voltage <sup>2</sup> | --   | --   | 1.3  | V     | $I_S=15A, V_{GS}=0V$        |
| $t_{rr}$ | Reverse Recovery Time <sup>2</sup> | --   | 27   | --   | nS    | $V_{GS}=0V$                 |
| $Q_{rr}$ | Reverse Recovery Charge            | --   | 26   | --   | nC    | $I_S=15A, di/dt=100A/\mu s$ |

Notes:

- \*1. Pulse width limited by max. junction temperature
- \*2. Pulse test
- \*3. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board,

Typical Feature curve

Figure1. Typical Output Characteristics

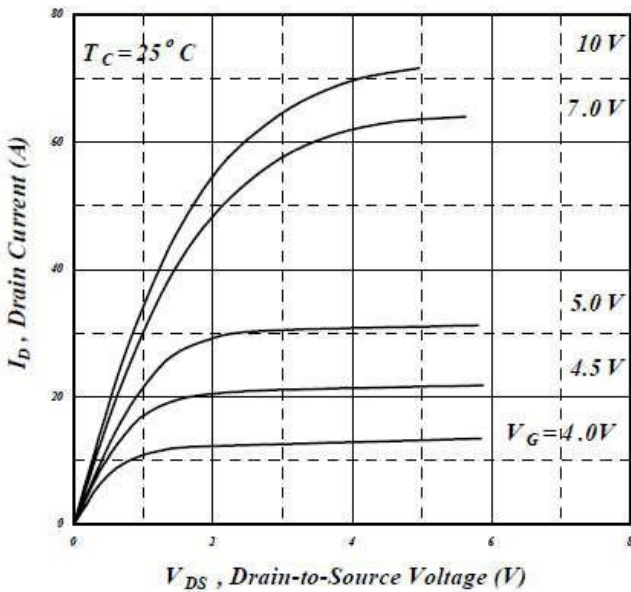
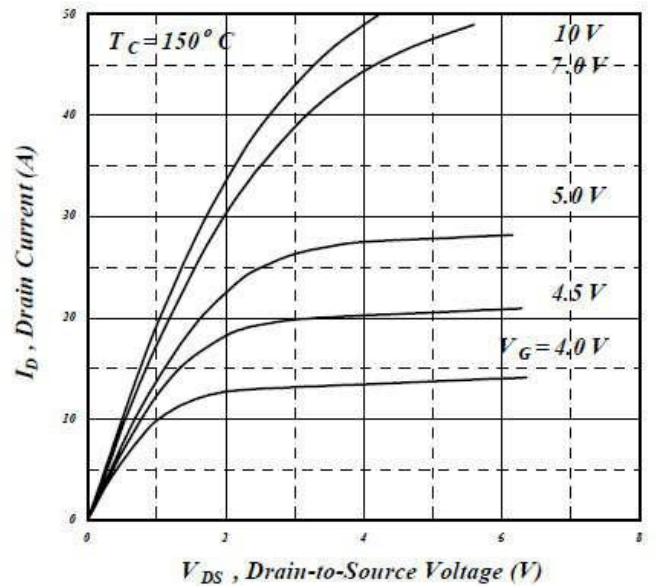
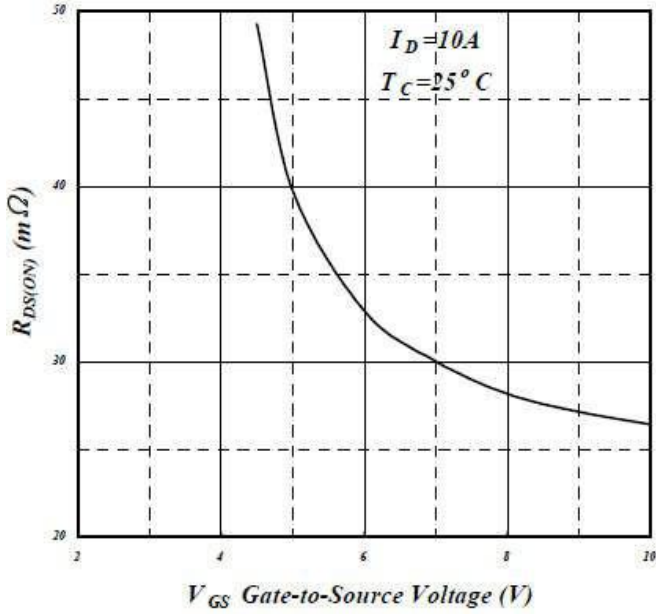


Figure2. Typical Output Characteristics



Figuer3. Typical ON Resistance V.S Gate Voltage



Figuer4. Normalized On-Resistance V.S Junction Temperature

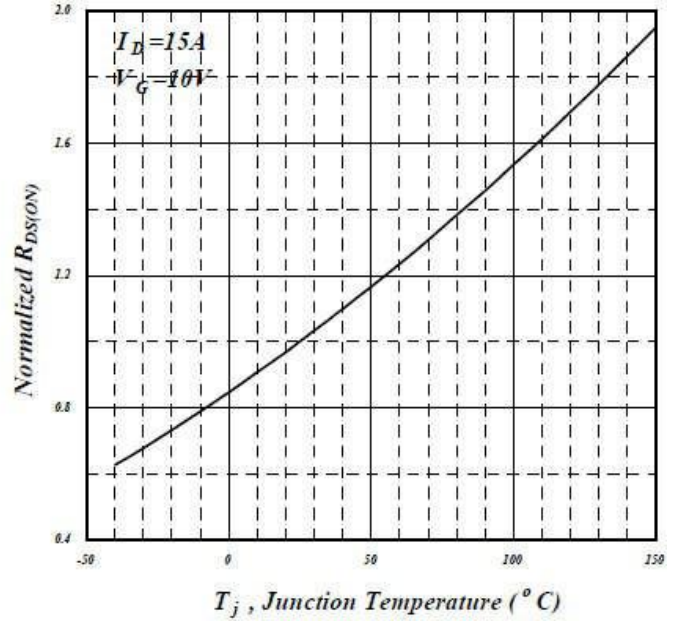


Figure5. Forward Characteristic of Reverse Diode

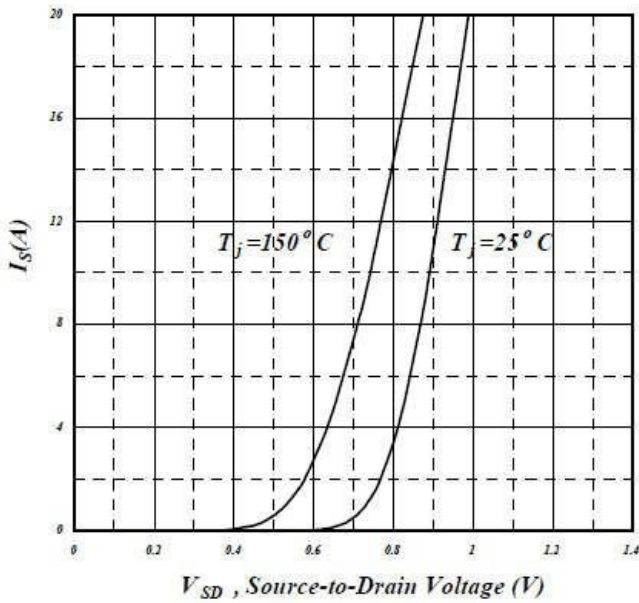


Figure6. Gate Threshold Voltage V.S Junction Temperature

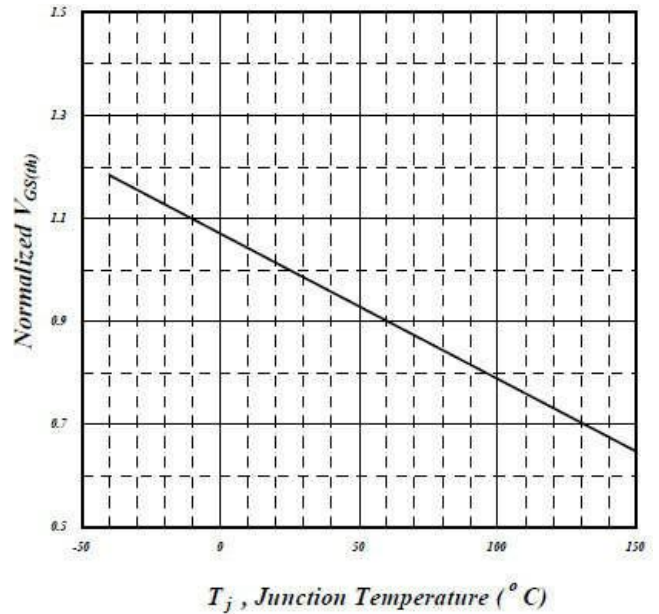


Figure7. Gate Charge Characteristics

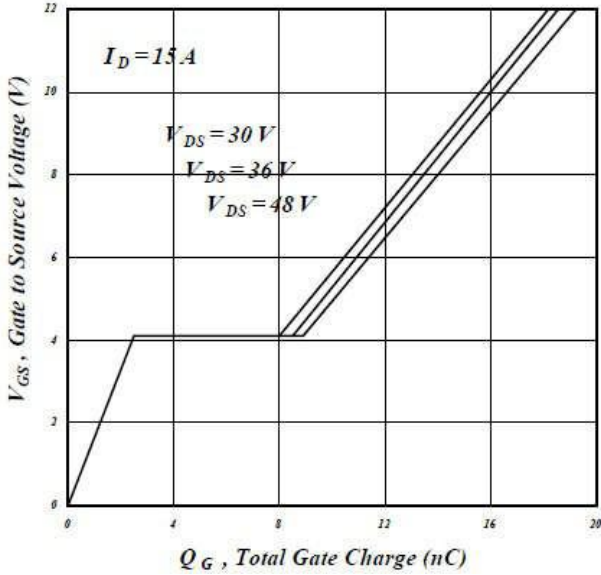


Figure8. Typical Capacitance Characteristics

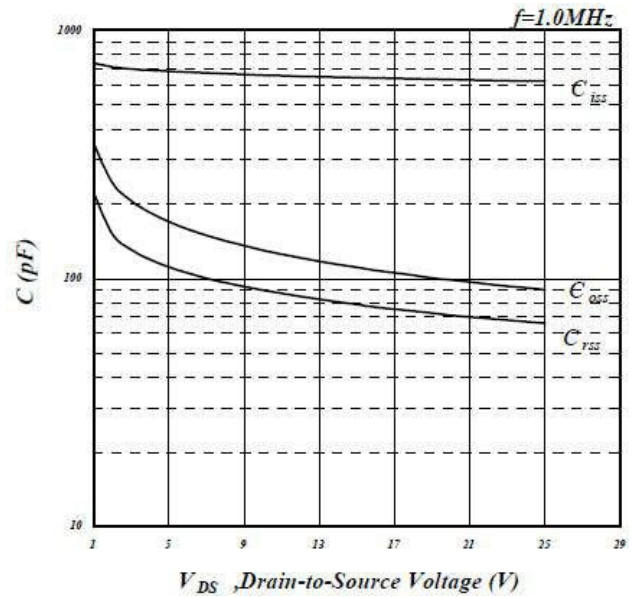


Figure9. Maximum Safe Operating Area

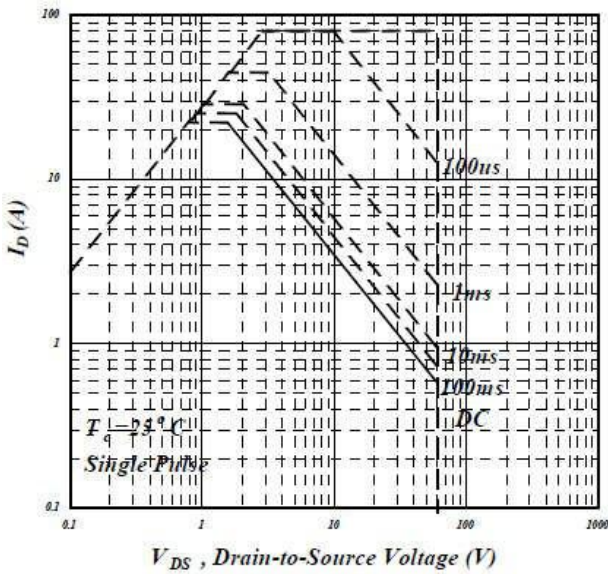


Figure10. Effective Transient Thermal Impedance

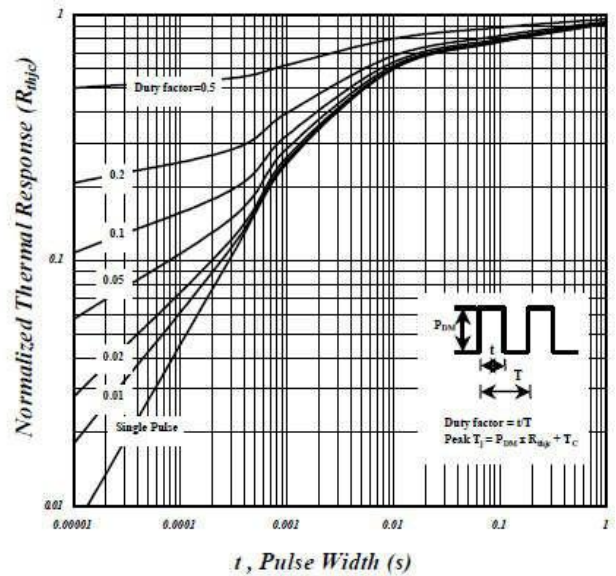


Figure11.  
Switching Time Waveform

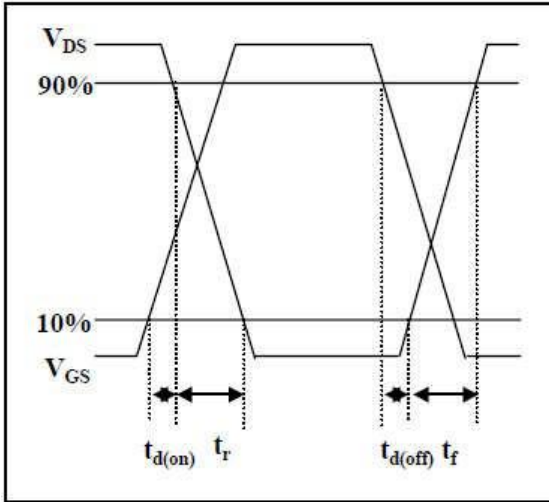
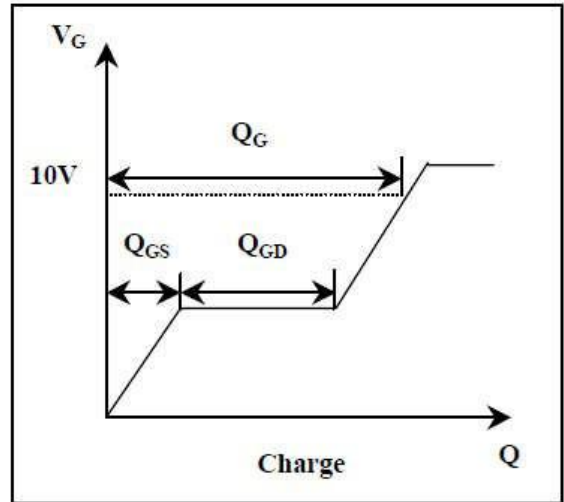
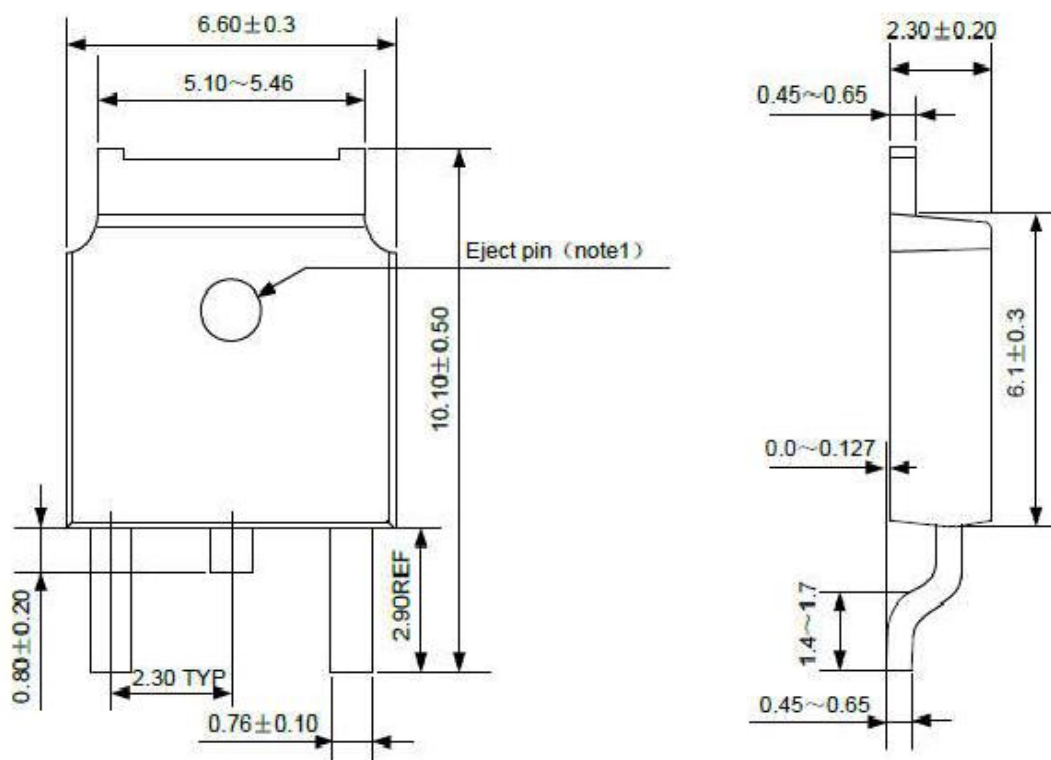


Figure12.  
Gate Charge Waveform



Package Outline: T0-252

Unit:mm



Note: The location is divided into top pinhole with no top pinhole two conditions

**TO-252 FOOTPRINT :**

